

Search Notes**Application/Control No.**

10/760,505

Examiner

LOIS ZHENG

**Applicant(s)/Patent under
Reexamination**

HIRAIWA ET AL.

Art Unit

1793

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
inventorship search	3/19/2008	LLZ
Updated EAST search	3/19/2008	LLZ